

## **Description**

The AP50P06P uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### **General Features**

 $V_{DS} = -60V I_{D} = -50A$ 

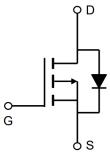
 $R_{DS(ON)}$  < -18m $\Omega$  @  $V_{GS}$ =-10V

## **Application**

Battery protection

Load switch

Uninterruptible power supply







**Package Marking and Ordering Information** 

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Product ID	Pack	Marking	Qty(PCS)
AP50P06P	TO-220-3L	AP50P06P XXX YYYY	1000
AP50P06T	TO-263-3L	AP50P06T XXX YYYY	1000

### Absolute Maximum Ratings (TC=25°C unless otherwise specified)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	-60	V
Vgs	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current <sup>1</sup>	-50	A
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current <sup>1</sup>	-34	A
Ірм	Pulsed Drain Current <sup>2</sup>	-90	А
EAS	Single Pulse Avalanche Energy <sup>3</sup>	101	mJ
las	Avalanche Current	-45	А
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	86.8	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-Ambient <sup>1</sup>	62	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	1.44	°C/W



### **Electrical Characteristics (Tc=25** ℃ unless otherwise noted)

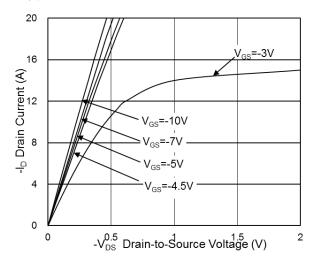
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-60			V
		V <sub>GS</sub> =-10V , I <sub>D</sub> =-18A		13	18	
Rds(on)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-12A		29	35	mΩ
V <sub>G</sub> S(th)	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1.0	1.8	-3.0	V
Ipss	Drain Source Leakage Current	V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	uA
Igss	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-10V , I <sub>D</sub> =-18A		23		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		7	14	
Qg	Total Gate Charge (-4.5V)			25		
Qgs	Gate-Source Charge	$V_{DS}$ =-20V , $V_{GS}$ =-4.5V , $I_{D}$ =-12A		6.7		nC
Qgd	Gate-Drain Charge			5.5		
Td(on)	Turn-On Delay Time			38		
Tr	Rise Time	$V_{DD}$ =-15V , $V_{GS}$ =-10V , $R_{G}$ =3.3 ,		23.6		
Td(off)	Turn-Off Delay Time	I <sub>D</sub> =-1A		100		ns
Tf	Fall Time	_		6.8		
Ciss	Input Capacitance			3635		
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		224		pF
Crss	Reverse Transfer Capacitance			141		
ls	Continuous Source Current <sup>1,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-20	Α
VsD	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1	V

#### Note:

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%
- 3.The EAS data shows Max. rating . The test condition is  $V_{DD}$ =-25V, $V_{GS}$ =-10V,L=0.1mH, $I_{AS}$ =-45A
- 4. The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



### **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

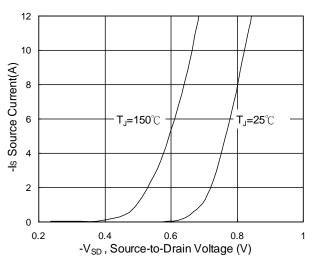


Fig.3 Source Drain Forward Characteristics

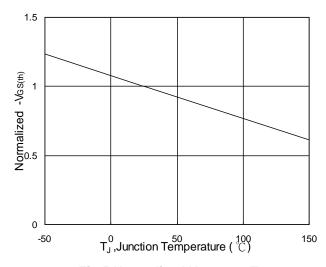


Fig.5 Normalized  $V_{\text{GS(th)}}$  vs.  $T_{\text{J}}$ 

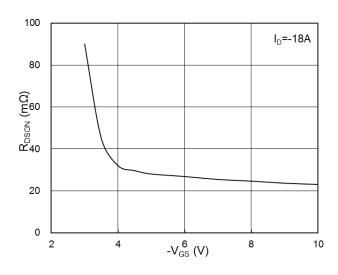


Fig.2 On-Resistance vs. G-S Voltage

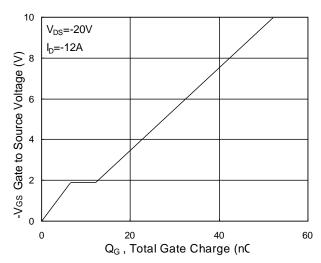


Fig.4 Gate-Charge Characteristics

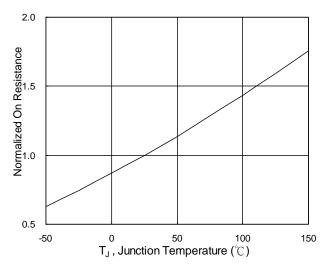
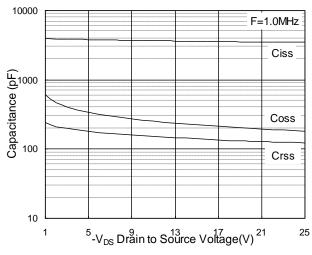


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>







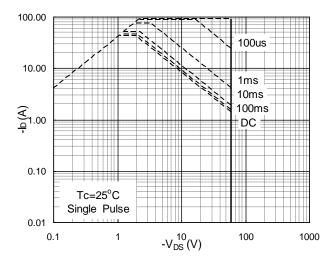


Fig.7 Capacitance

Fig.8 Safe Operating Area

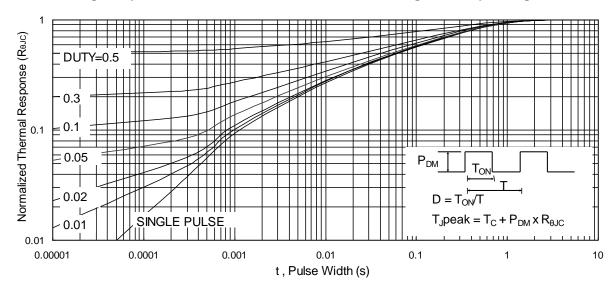
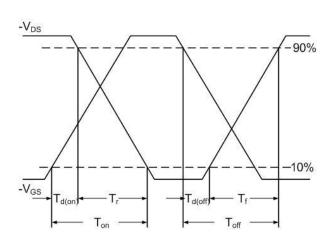


Fig.9 Normalized Maximum Transient Thermal Impedance



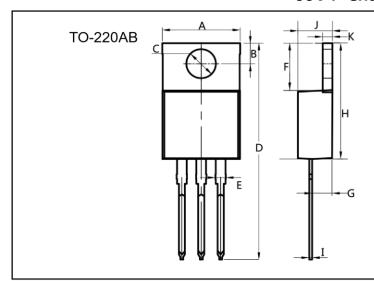
-I<sub>AS</sub>

EAS=  $\frac{1}{2}$  L x (-I<sub>AS</sub><sup>2</sup>)x  $\frac{-BV_{DSS}}{-BV_{DSS}-(-V_{DD})}$ 

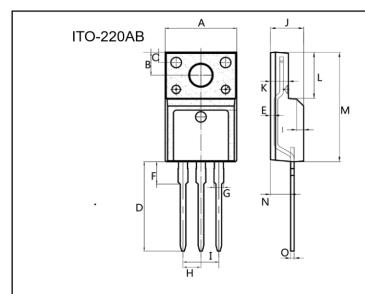
Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Waveform

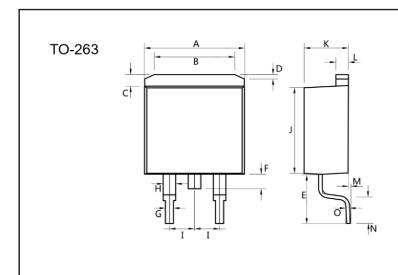




Dim.	Min.	Max.
Α	10.0	10.4
В	2.5	3.0
С	3.5	4.0
D	28.0	30.0
E	1.1	1.5
F	6.2	6.6
G	2.9	3.3
Н	15.0	16.0
I	0.35	0.45
J	4.3	4.7
K	1.2	1.4
All Dimensions in millimeter		



Dim.	Min.	Max.
Α	9.9	10.3
В	2.9	3.5
С	1.15	1.45
D	12.75	13.25
E	0.55	0.75
F	3.1	3.5
G	1.25	1.45
Н	Typ 2.54	
I	Тур	5.08
J	4.55	4.75
K	2.4	2. 7
L	6.35	6.75
М	15.0	16.0
N	2.75	3.15
0	0.45	0.60
All Dimensions in millimeter		



Dim.	Min.	Max.
Α	10.0	10. 5
В	7.25	7.75
С	1.3	1.5
D	0.55	0.75
E	5.0	6.0
F	1.4	1.6
G	0.75	0.95
Н	1.15	1.35
1	Тур	2.54
J	Тур 8.4	2.54 8.6
<u> </u>		
J	8.4	8.6
J K	8.4 4.4	8.6 4.6
J K L	8.4 4.4 1.25	8.6 4.6 1.45
J K L	8.4 4.4 1.25 0.02	8.6 4.6 1.45 0.1
J K L M N	8.4 4.4 1.25 0.02 2.4	8.6 4.6 1.45 0.1 2.8 0.45



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